


<b>Search Notes</b>  	<b>Application/Control No.</b>  10645097	<b>Applicant(s)/Patent Under Reexamination</b>  LEE, CHIOU-HAUN
	<b>Examiner</b>  Patel, Kanji	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
382	254, 312	1/28/07	KBP
385	120	2/2/07	KBP
358	1.9	2/2/07	KBP
430	394	2/2/07	KBP

SEARCH NOTES		
Search Notes	Date	Examiner
INVENTOR SEARCH IN PALM	1/26/07	KBP
EAST (US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB)	1/26/07	KBP
EAST (US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB)	1/29/07	1BP
NPL-IEEE XPLORE SEARCH	1/29/07	KBP
INTERFERENCE SEARCH HISTORY PRINTOUT	2/2/07	KBP
EAST (USPAT)	2/2/07	KBP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
382	254	1/29/07	KBP
358	1.9	1/29/07	KBP